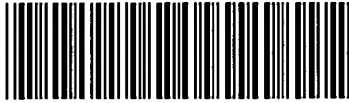


Search Notes

Application No.

09/802,464

Examiner

José R. Díaz

Applicant(s)

BAWOLEK ET AL.

Art Unit

2815

SEARCHED

Class	Subclass	Date	Examiner
257	434, 435, 440, 443, 448, 457	7/20/2004	JRD
257	459	7/20/2004	JRD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Discussed with Tom Thomas	7/15/2004	JRD
Discussed with Bill Baumeister 257/434,435,440,443,448,457,459 (photo-diode, light detector, photo- detector,	7/20/2004	JRD
p-i-n or pin diode, and pixel) in combination with (area, size geometry shape, opening)	7/20/2004	JRD
Text Search: East (see attachment)	7/20/2004	JRD